OptiMOS™-T2 Power-Transistor

AEC Qualified

RoHS

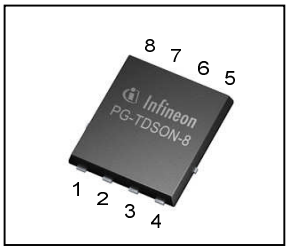
Product Summary

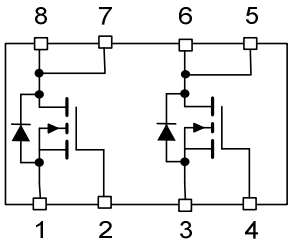
V_{DS}	40	V
$R_{DS(on),max}$ [4]	11.6	mΩ
I_D	20	A

Features

- Dual N-channel Logic Level - Enhancement mode
- AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green Product (RoHS compliant)
- 100% Avalanche tested

PG-TDSON-8-4





Type	Package	Marking
IPG20N04S4L-11	PG-TDSON-8-4	4N04L11

Maximum ratings, at T_j=25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current one channel active	I_D	T_C=25 °C, V_{GS}=10 V [1]	20	A
		T_C=100 °C, V_{GS}=10 V [2]	20	
Pulsed drain current [2] one channel active	$I_{D,pulse}$	-	80	
Avalanche energy, single pulse [2, 4]	E_{AS}	I_D=10A	80	mJ
Avalanche current, single pulse [4]	I_{AS}	-	15	A
Gate source voltage	V_{GS}	-	±16	V
Power dissipation one channel active	P_{tot}	T_C=25 °C	41	W
Operating and storage temperature	T_j, T_{stg}	-	-55 ... +175	°C

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics[2]						
Thermal resistance, junction - case	R_{thJC}	-	-	-	3.7	K/W
SMD version, device on PCB	R_{thJA}	minimal footprint	-	100	-	
		6 cm^2 cooling area[3]	-	60	-	
Electrical characteristics, at T_j=25 °C, unless otherwise specified						
Static characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	V_{GS}=0 V, I_D= 1 mA	40	-	-	V
Gate threshold voltage	$V_{GS(th)}$	V_{DS}=V_{GS}, I_D= 15µA	1.2	1.7	2.2	
Zero gate voltage drain current[4]	I_{DSS}	V_{DS}=40 V, V_{GS}=0 V, T_j=25 °C	-	0.01	1	µA
		V_{DS}=18 V, V_{GS}=0 V, T_j=85 °C[2]	-	1	100	
Gate-source leakage current[4]	I_{GSS}	V_{GS}=16 V, V_{DS}=0 V	-	-	100	nA
Drain-source on-state resistance[4]	$R_{DS(on)}$	V_{GS}=4.5 V, I_D=10A	-	13.1	15.5	mΩ
		V_{GS}=10 V, I_D=17A	-	10.1	11.6	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics[2]						
Input capacitance[4]	C_{iss}	V_{GS}=0 V, V_{DS}=25 V, f=1 MHz	-	1530	1990	pF
Output capacitance[4]	C_{oss}		-	300	390	
Reverse transfer capacitance[4]	C_{rss}		-	13	30	
Turn-on delay time	$t_{d(on)}$	V_{DD}=20 V, V_{GS}=10 V, I_D=20 A, R_G=11 Ω	-	5	-	ns
Rise time	t_r		-	2	-	
Turn-off delay time	$t_{d(off)}$		-	25	-	
Fall time	t_f		-	15	-	
Gate Charge Characteristics[2, 4]						
Gate to source charge	Q_{gs}	V_{DD}=32 V, I_D=20 A, V_{GS}=0 to 10 V	-	4.5	5.9	nC
Gate to drain charge	Q_{gd}		-	2.2	5.1	
Gate charge total	Q_g		-	20	26	
Gate plateau voltage	$V_{plateau}$		-	2.9	-	V
Reverse Diode						
Diode continous forward current[2] one channel active	I_S	T_C=25 °C	-	-	20	A
Diode pulse current[2] one channel active	$I_{S,pulse}$		-	-	80	
Diode forward voltage	V_{SD}	V_{GS}=0 V, I_F=17 A, T_j=25 °C	-	0.9	1.3	V
Reverse recovery time[2]	t_{rr}	V_R=20 V, I_F=I_S, di_F/dt=100 A/µs	-	32	-	ns
Reverse recovery charge[2, 4]	Q_{rr}		-	25	-	nC

[1] Current is limited by bondwire; with an R_{thJC}=3.7 K/W the chip is able to carry 46A at 25°C.

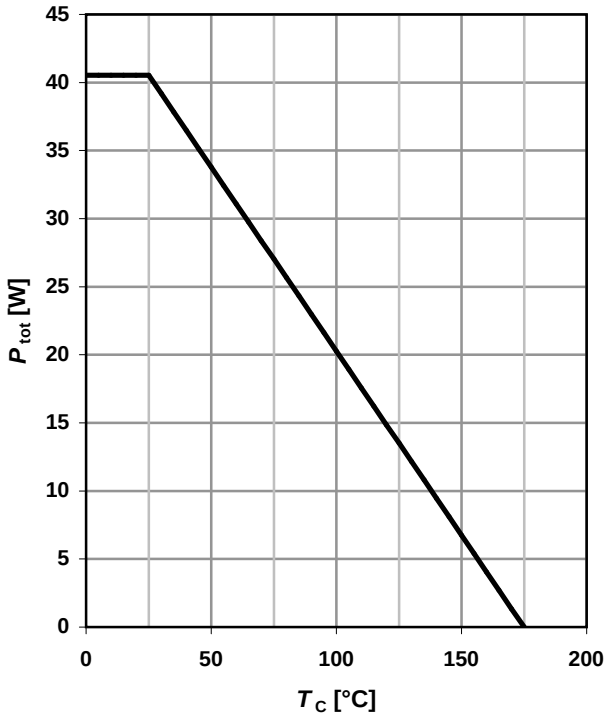
[2] Specified by design. Not subject to production test.

[3] Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm^2 (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

[4] Per channel

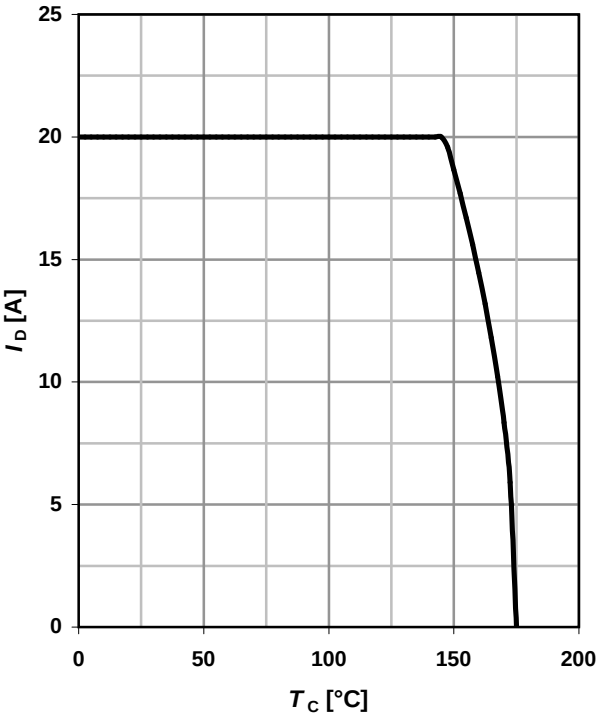
1 Power dissipation

$P_{tot} = f(T_C)$; $V_{GS} \geq 6$ V; one channel active



2 Drain current

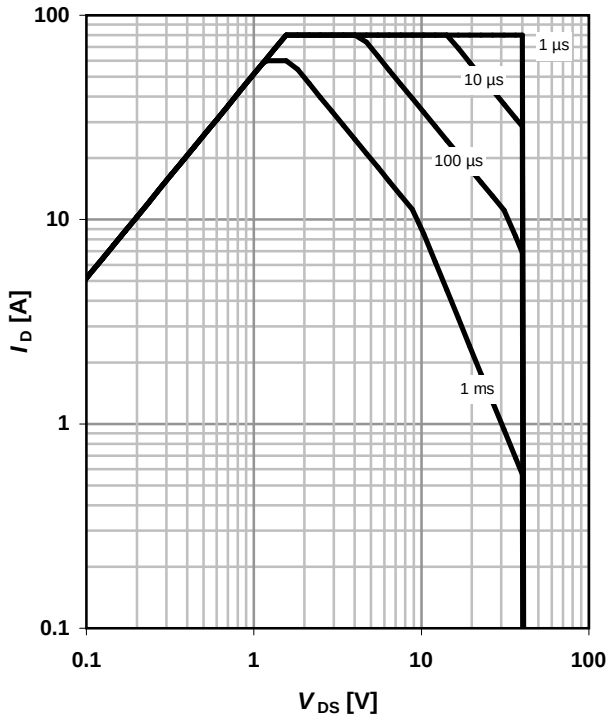
$I_D = f(T_C)$; $V_{GS} \geq 6$ V; one channel active



3 Safe operating area

$I_D = f(V_{DS})$; $T_C = 25$°C; $D = 0$; one channel active

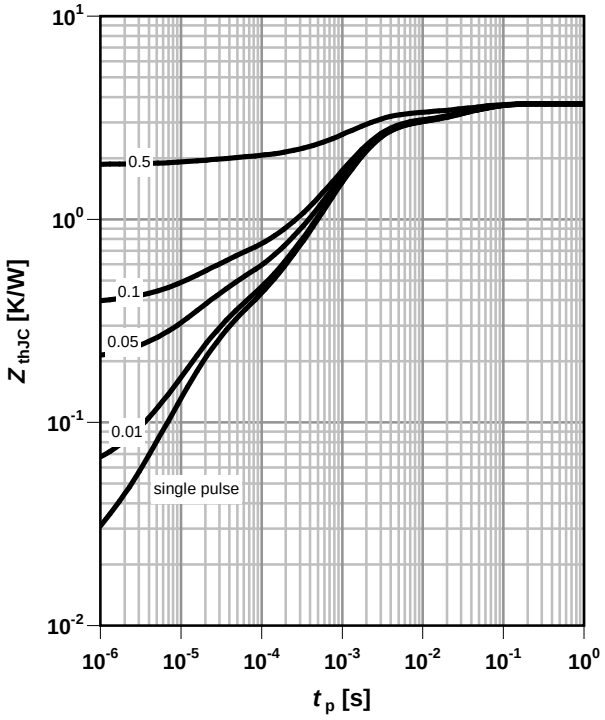
parameter: t_p



4 Max. transient thermal impedance

$Z_{thJC} = f(t_p)$

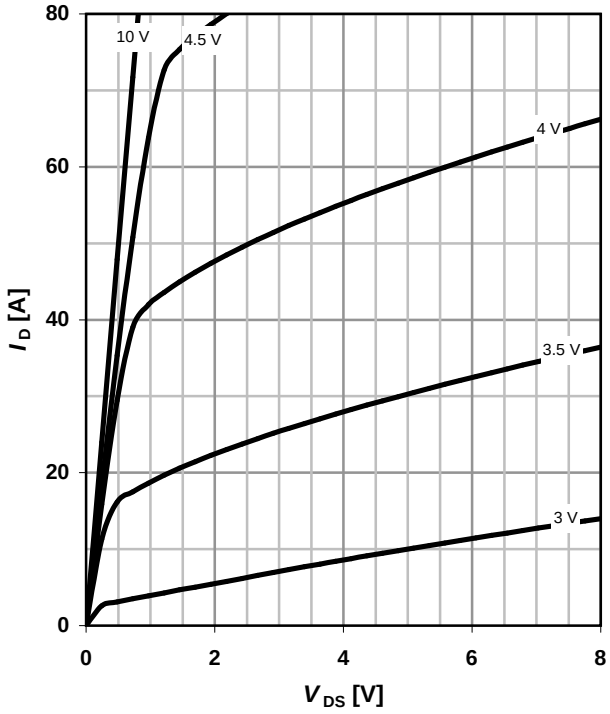
parameter: $D = t_p/T$



5 Typ. output characteristics[4)]

$I_D = f(V_{DS})$; $T_j = 25$ °C

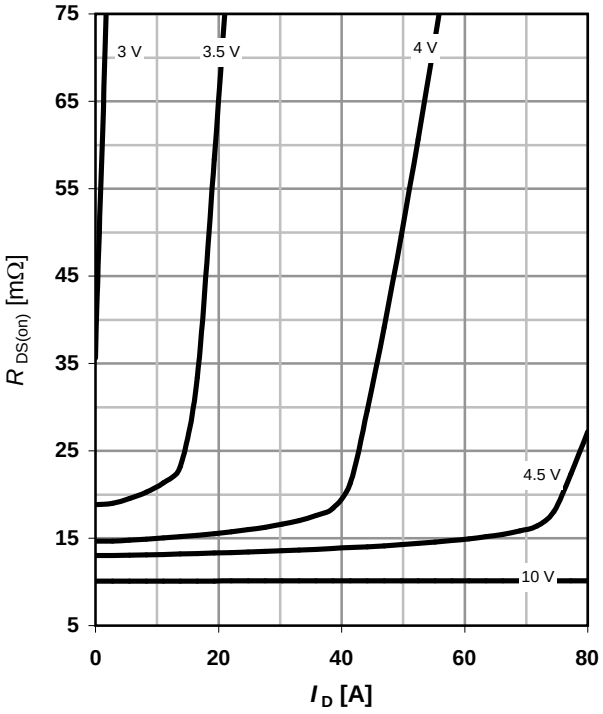
parameter: V_{GS}



6 Typ. drain-source on-state resistance[4)]

$R_{DS(on)} = f(I_D)$; $T_j = 25$ °C

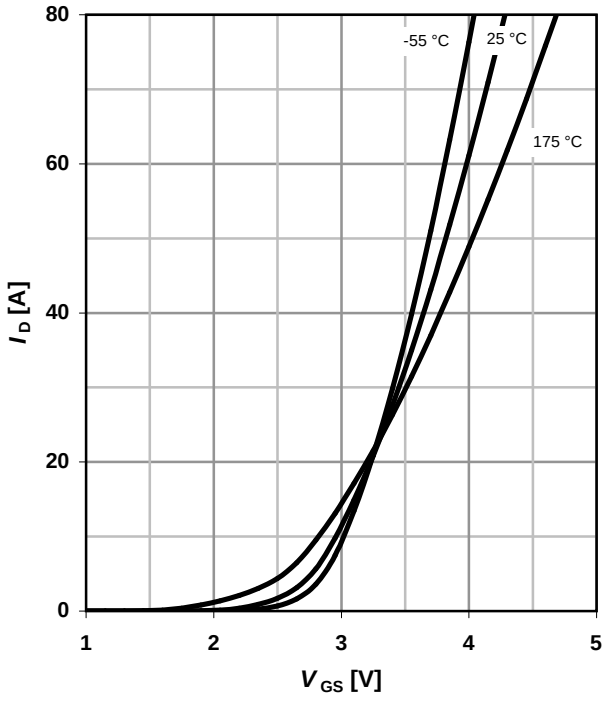
parameter: V_{GS}



7 Typ. transfer characteristics[4)]

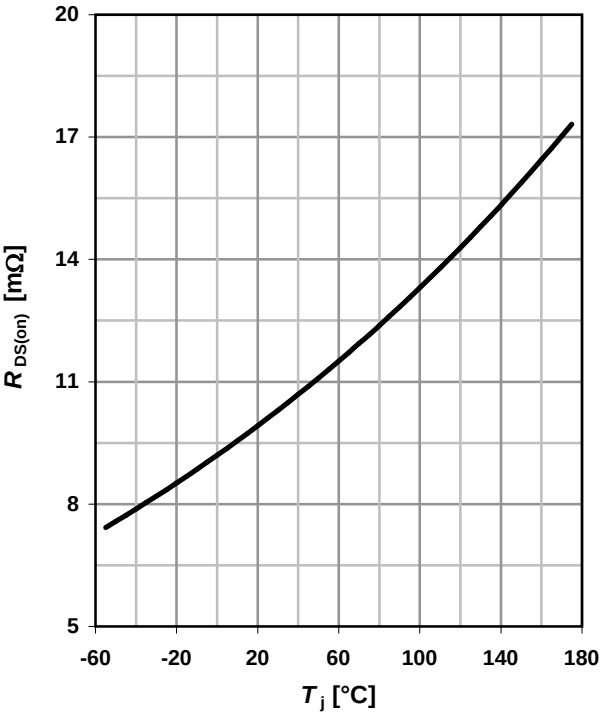
$I_D = f(V_{GS})$; $V_{DS} = 6$V

parameter: T_j



8 Typ. drain-source on-state resistance[4)]

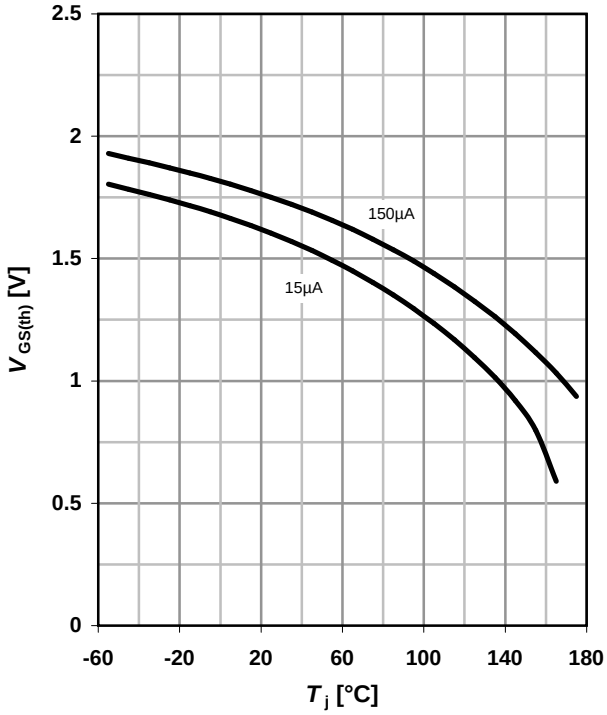
$R_{DS(on)} = f(T_j)$; $I_D = 17$ A; $V_{GS} = 10$ V



9 Typ. gate threshold voltage

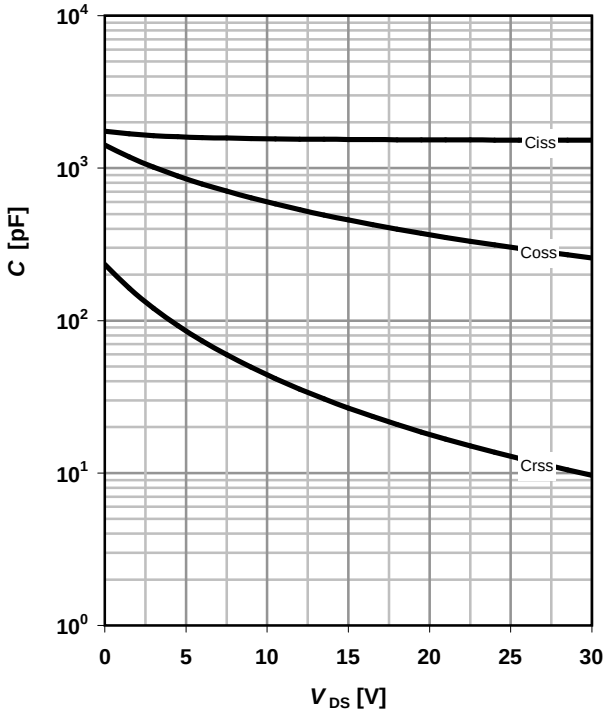
$V_{GS(th)} = f(T_j)$; $V_{GS} = V_{DS}$

parameter: I_D



10 Typ. Capacitances[4)]

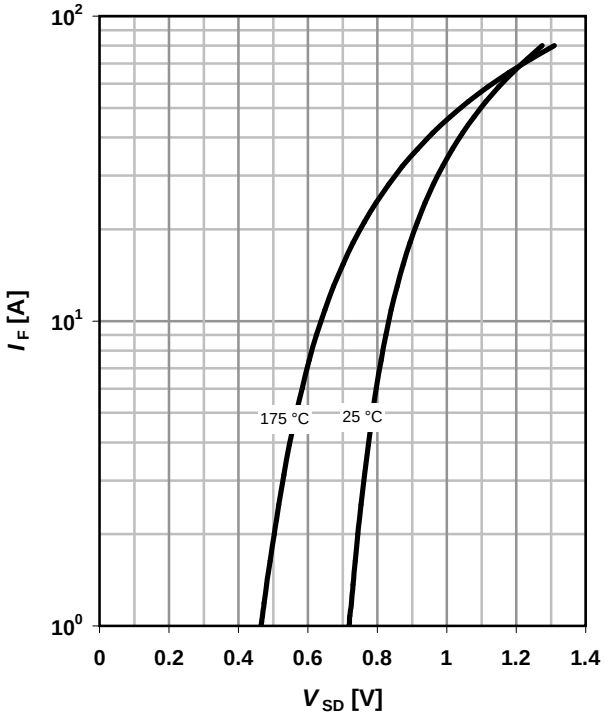
$C = f(V_{DS})$; $V_{GS} = 0$ V; $f = 1$ MHz



11 Typical forward diode characteristicis[4)]

IF = f(V_{SD})

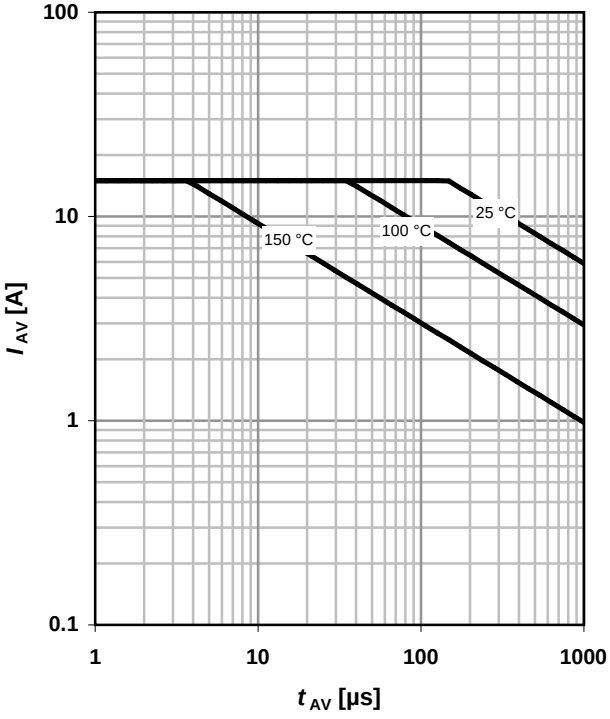
parameter: T_j



12 Avalanche characteristics[4)]

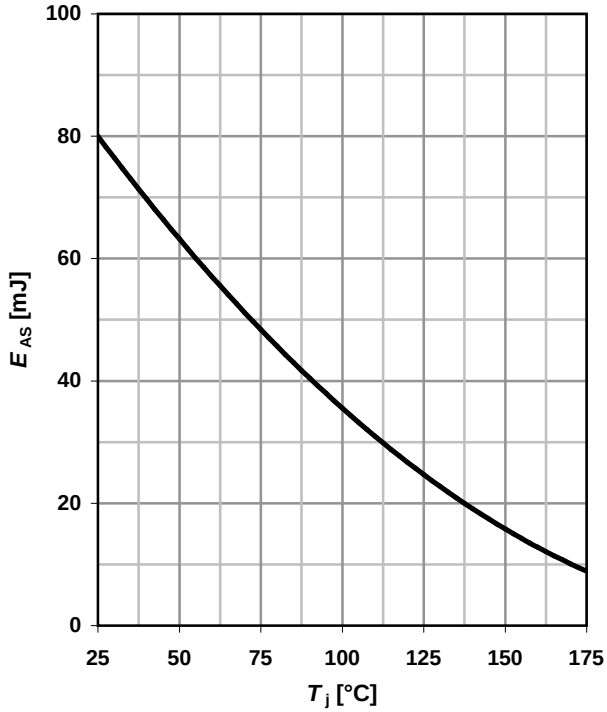
$I_{AS} = f(t_{AV})$

parameter: $T_{j(start)}$



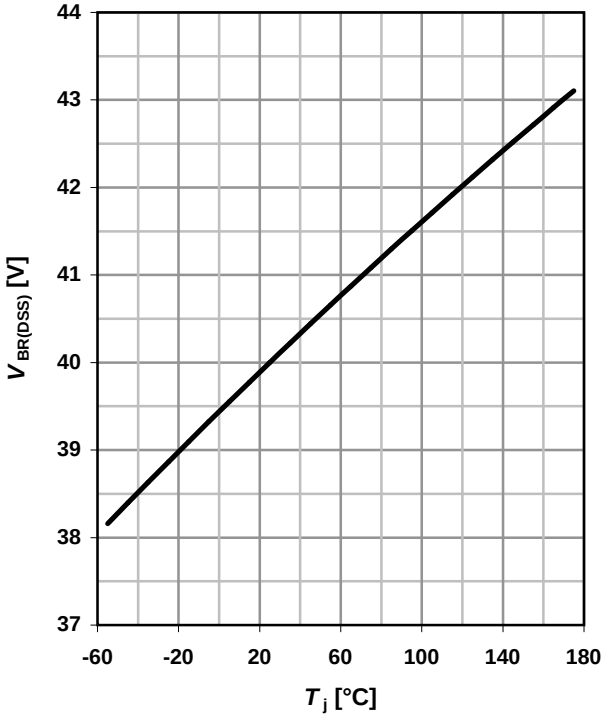
13 Avalanche energy[4)]

$E_{AS} = f(T_j)$, $I_D = 10A$



14 Drain-source breakdown voltage

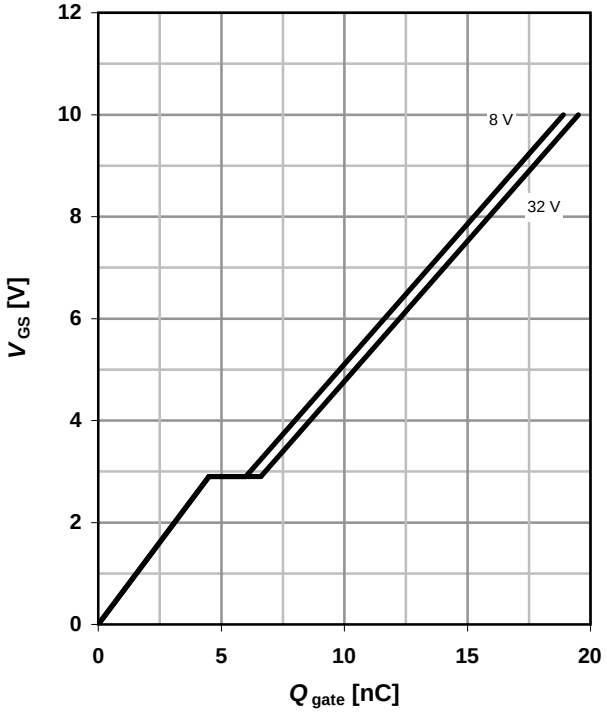
$V_{BR(DSS)} = f(T_j)$; $I_D = 1$ mA



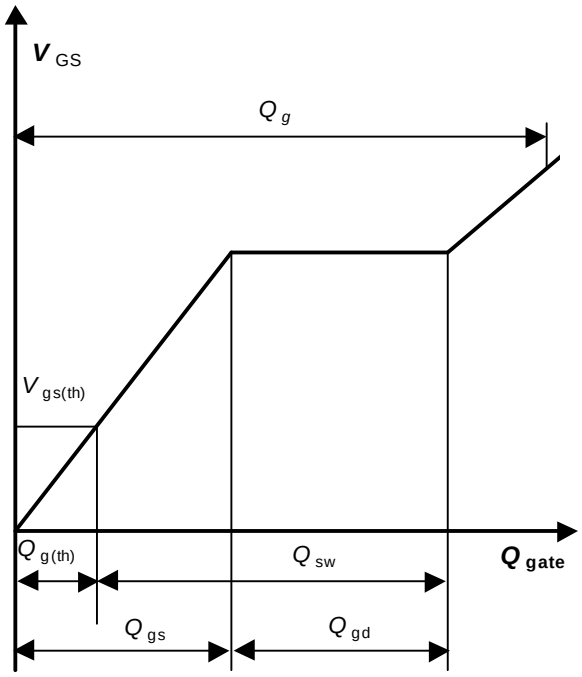
15 Typ. gate charge[4)]

$V_{GS} = f(Q_{gate})$; $I_D = 20$ A pulsed

parameter: V_{DD}



16 Gate charge waveforms



Published by
Infineon Technologies AG
81726 Munich, Germany

Legal Disclaimer
The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Information
For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

Warnings
Due to technical requirements, components may contain dangerous substances.
For information on the types in question, please contact the nearest Infineon Technologies Office.
Infineon Technologies components may be used in life-support devices or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life.
If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

Revision History

Version	Date	Changes
Revision 1.0	05.10.2010	Data Sheet revision 1.0

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET ***category:***

Click to view products by Infineon ***manufacturer:***

Other Similar products are found below :

614233C 648584F MCH3443-TL-E MCH6422-TL-E FDPF9N50NZ FW216A-TL-2W FW231A-TL-E APT5010JVR NTNS3A92PZT5G IRF100S201 JANTX2N5237 2SK2464-TL-E 2SK3818-DL-E FCA20N60_F109 FDZ595PZ STD6600NT4G FSS804-TL-E 2SJ277-DL-E 2SK1691-DL-E 2SK2545(Q,T) D2294UK 405094E 423220D MCH6646-TL-E TPCC8103,L1Q(CM 367-8430-0972-503 VN1206L 424134F 026935X 051075F SBVS138LT1G 614234A 715780A NTNS3166NZT5G 751625C 873612G IRF7380TRHR IPS70R2K0CEAKMA1 RJK60S3DPP-E0#T2 RJK60S5DPK-M0#T0 APT5010JVFR APT12031JFLL APT12040JVR DMN3404LQ-7 NTE6400 JANTX2N6796U JANTX2N6784U JANTXV2N5416U4 SQM110N05-06L-GE3 SIHF35N60E-GE3